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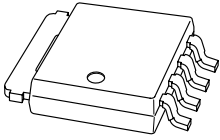Should be replaced with:
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Kind regards,

Team Nexperia

PH1875L
N-channel TrenchMOS logic level FET

Rev. 01 — 29 November 2005   **Product data sheet**

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Logic level threshold
- Low thermal resistance
- Very low on-state resistance
- Surface-mounted package

1.3 Applications

- DC motor control
- DC-to-DC converters
- General purpose power switching

1.4 Quick reference data

- $V_{DS} \leq 75$ V
- $R_{DSon} \leq 16.5$ mΩ
- $I_D \leq 45.8$ A
- $Q_{GD} = 15.3$ nC (typ)

2. Pinning information

Table 1:   Pinning

Pin	Description	Simplified outline	Symbol
1, 2, 3	source (S)		
4	gate (G)		
mb	mounting base; connected to drain (D)		

SOT669 (LFPAK)

mb

1 2 3 4

D

G

S

mbb076

PHILIPS

3. Ordering information

Table 2:   Ordering information

Type number	Package		Version
	Name	**Description**	
PH1875L	LFPAK	plastic single-ended surface mounted package; 4 leads	SOT669

4. Limiting values

Table 3:   Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

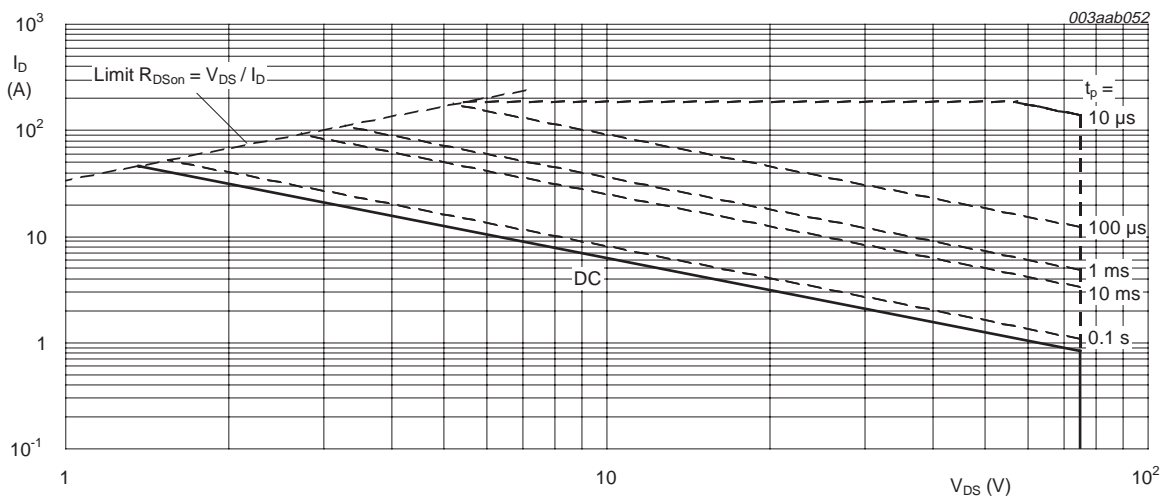| Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	25 °C $\leq T_j \leq$ 150 °C	-	75	V
V_{DGR}	drain-gate voltage (DC)	25 °C $\leq T_j \leq$ 150 °C; R_{GS} = 20 kΩ	-	75	V
V_{GS}	gate-source voltage		-	±15	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see Figure 2 and 3	-	45.8	A
		T_{mb} = 100 °C; V_{GS} = 10 V; see Figure 2	-	29	A
I_{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \leq$ 10 µs; see Figure 3	-	183	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 1	-	62.5	W
T_{stg}	storage temperature		−55	+150	°C
T_j	junction temperature		−55	+150	°C
Source-drain diode					
I_S	source current	T_{mb} = 25 °C	-	45.8	A
I_{SM}	peak source current	T_{mb} = 25 °C; pulsed; $t_p \leq$ 10 µs	-	183	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; I_D = 26 A; t_p = 0.11 ms; $V_{DS} \leq$ 75 V; R_{GS} = 50 Ω; V_{GS} = 10 V; starting at T_j = 25 °C	-	165	mJ
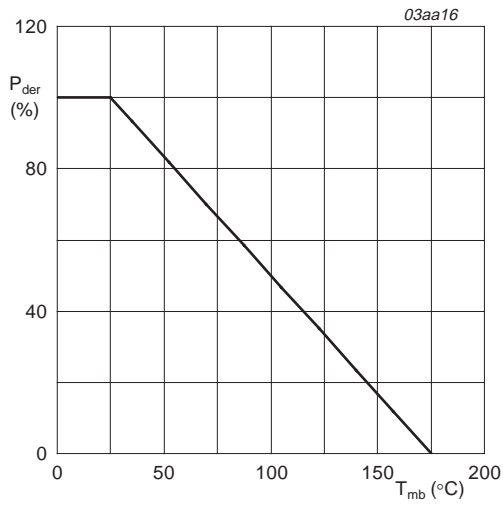
$$P_{der} = \frac{P_{tot}}{P_{tot(25\,°C)}} \times 100\,\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature
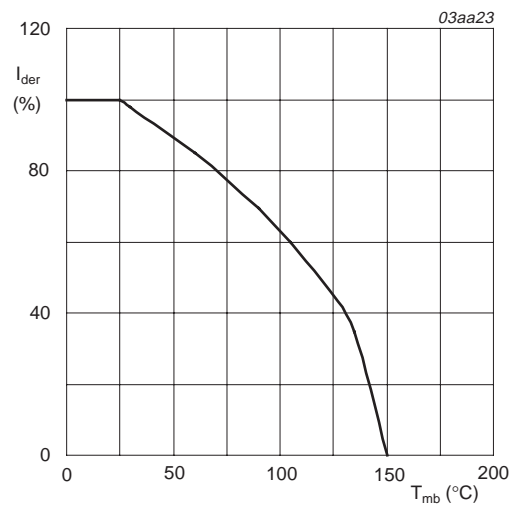
$$I_{der} = \frac{I_D}{I_{D(25\,°C)}} \times 100\,\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature

T_{mb} = 25 °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4: **Thermal characteristics**

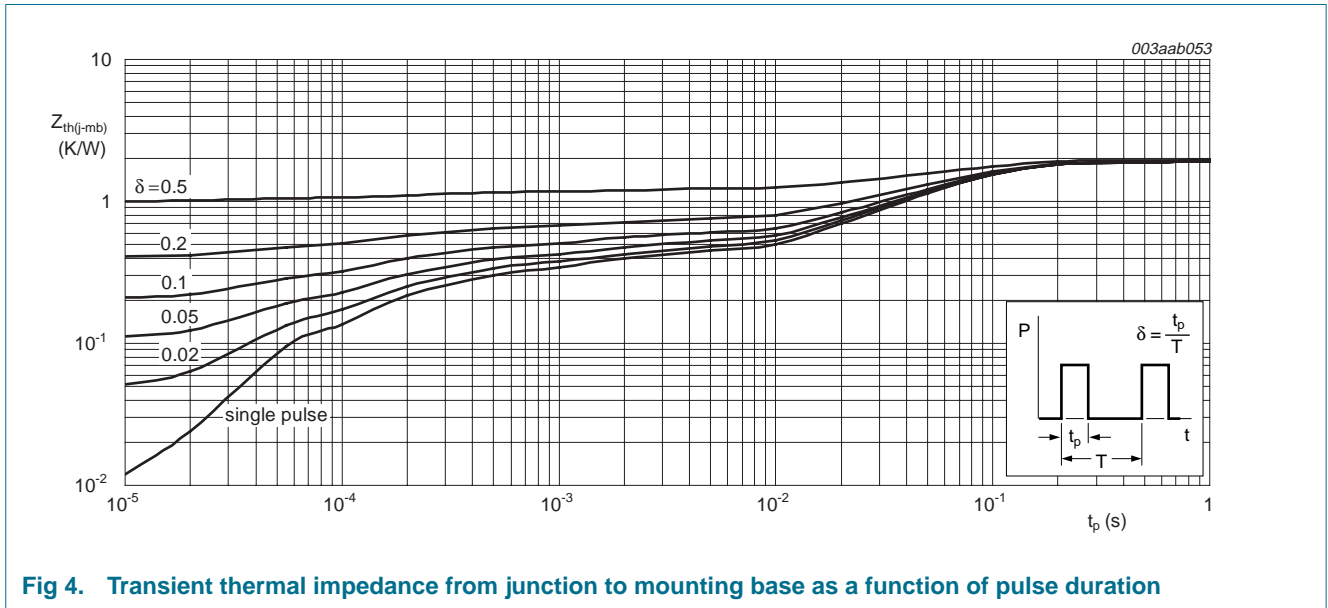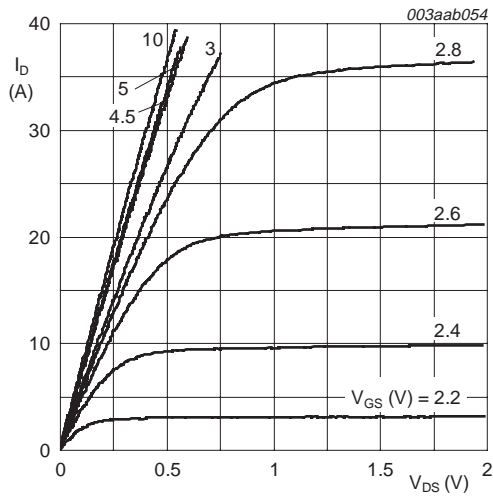| Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	2	K/W

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Fig 4. **Transient thermal impedance from junction to mounting base as a function of pulse duration**
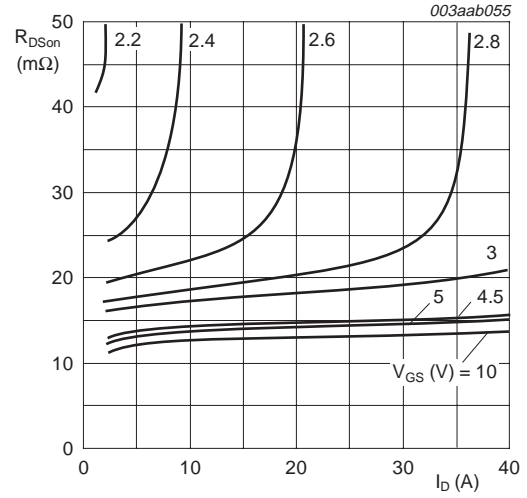
6. Characteristics

Table 5:   Characteristics

T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 250 µA; V_{GS} = 0 V				
		T_j = 25 °C	75	-	-	V
		T_j = −55 °C	68	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; see Figure 9 and 10				
		T_j = 25 °C	1	1.5	2	V
		T_j = 150 °C	0.5	-	-	V
		T_j = −55 °C	-	-	2.2	V
I_{DSS}	drain leakage current	V_{DS} = 75 V; V_{GS} = 0 V				
		T_j = 25 °C	-	-	1	µA
		T_j = 150 °C	-	-	500	µA
I_{GSS}	gate leakage current	V_{GS} = ±15 V; V_{DS} = 0 V	-	10	100	nA
R_G	gate resistance	f = 1 MHz	-	1	-	Ω
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 20 A; see Figure 6 and 8				
		T_j = 25 °C	-	13.3	16.5	mΩ
		T_j = 150 °C	-	24.2	30	mΩ
		V_{GS} = 4.5 V; I_D = 20 A; see Figure 6 and 8	-	14.6	20	mΩ
		V_{GS} = 5 V; I_D = 20 A; see Figure 6 and 8	-	14.2	18	mΩ
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	I_D = 25 A; V_{DS} = 60 V; V_{GS} = 5 V; see Figure 11 and 12	-	33.4	-	nC
Q_{GS}	gate-source charge		-	6.7	-	nC
Q_{GS1}	pre-$V_{GS(th)}$ gate-source charge		-	3.3	-	nC
Q_{GS2}	post-$V_{GS(th)}$ gate-source charge		-	3.4	-	nC
Q_{GD}	gate-drain charge		-	15.3	-	nC
$V_{GS(pl)}$	gate-source plateau voltage		-	3	-	V
$Q_{G(tot)}$	total gate charge	I_D = 0 A; V_{DS} = 0 V; V_{GS} = 4.5 V	-	23	-	nC
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz; see Figure 14	-	2 600	-	pF
C_{oss}	output capacitance		-	285	-	pF
C_{rss}	reverse transfer capacitance		-	150	-	pF
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 0 V; f = 1 MHz	-	4000	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 30 V; R_L = 1.2 Ω; V_{GS} = 5 V; R_G = 10 Ω	-	23	-	ns
t_r	rise time		-	80	-	ns
$t_{d(off)}$	turn-off delay time		-	92	-	ns
t_f	fall time		-	60	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	I_S = 25 A; V_{GS} = 0 V; see Figure 13	-	0.85	1.2	V
t_{rr}	reverse recovery time	I_S = 20 A; dI_S/dt = −100 A/µs; V_{GS} = 0 V; V_R = 30 V	-	107	-	ns
Q_r	recovered charge		-	124	-	nC

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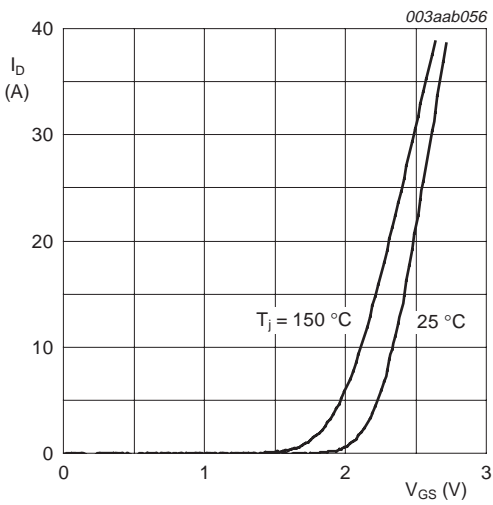
$T_j = 25\ °C$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

$T_j = 25\ °C$

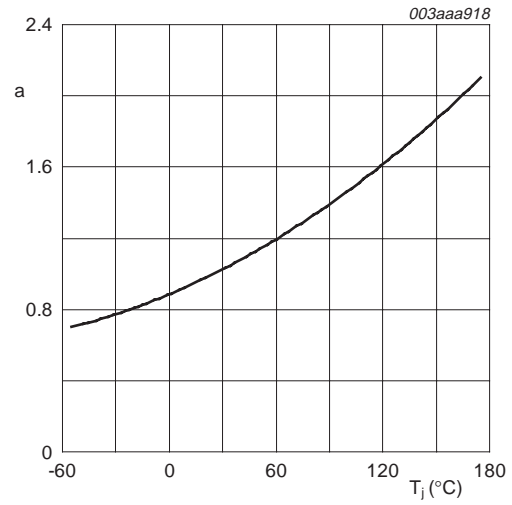**Fig 6. Drain-source on-state resistance as a function of drain current; typical values**

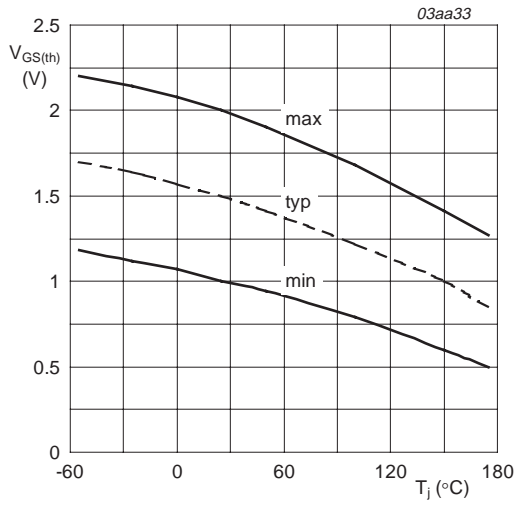$T_j = 25\ °C$ and $150\ °C$; $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

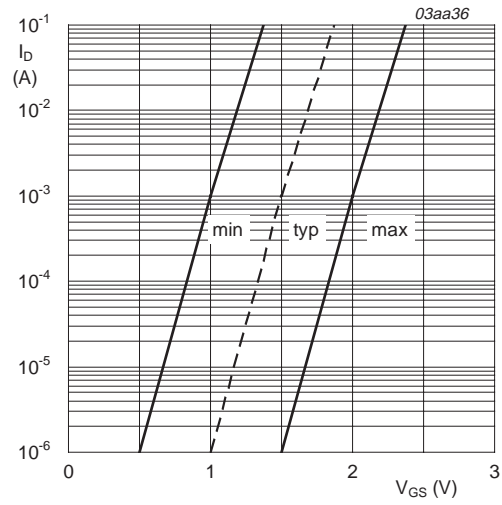$$a = \frac{R_{DSon}}{R_{DSon(25\ °C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

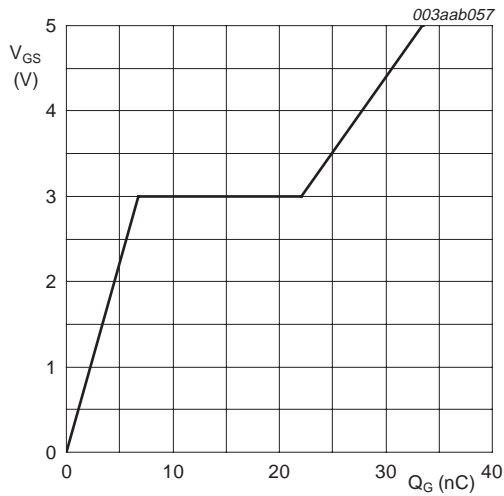I_D = 1 mA; V_{DS} = V_{GS}

Fig 9. **Gate-source threshold voltage as a function of junction temperature**

T_j = 25 °C; V_{DS} = 5 V

Fig 10. **Sub-threshold drain current as a function of gate-source voltage**

I_D = 25 A; V_{DS} = 60 V

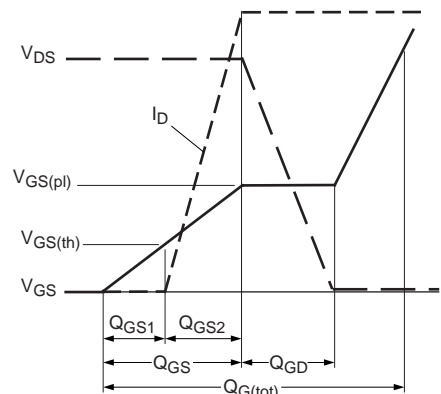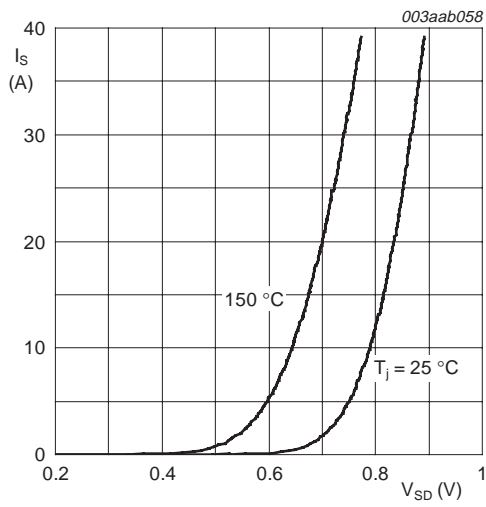**Fig 11.** **Gate-source voltage as a function of gate charge; typical values**

Fig 12. **Gate charge waveform definitions**

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T_j = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source current as a function of source-drain voltage; typical values

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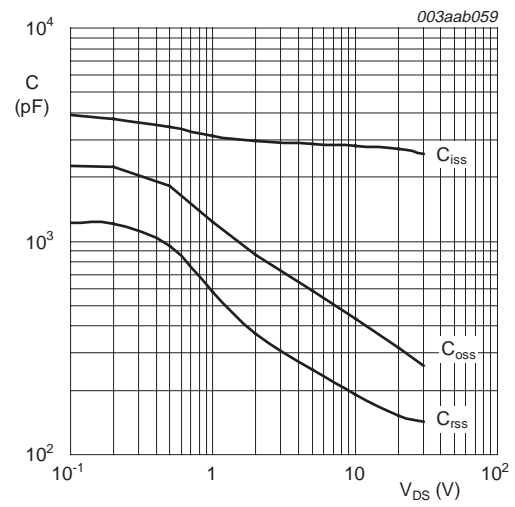
V_{GS} = 0 V; f = 1 MHz

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

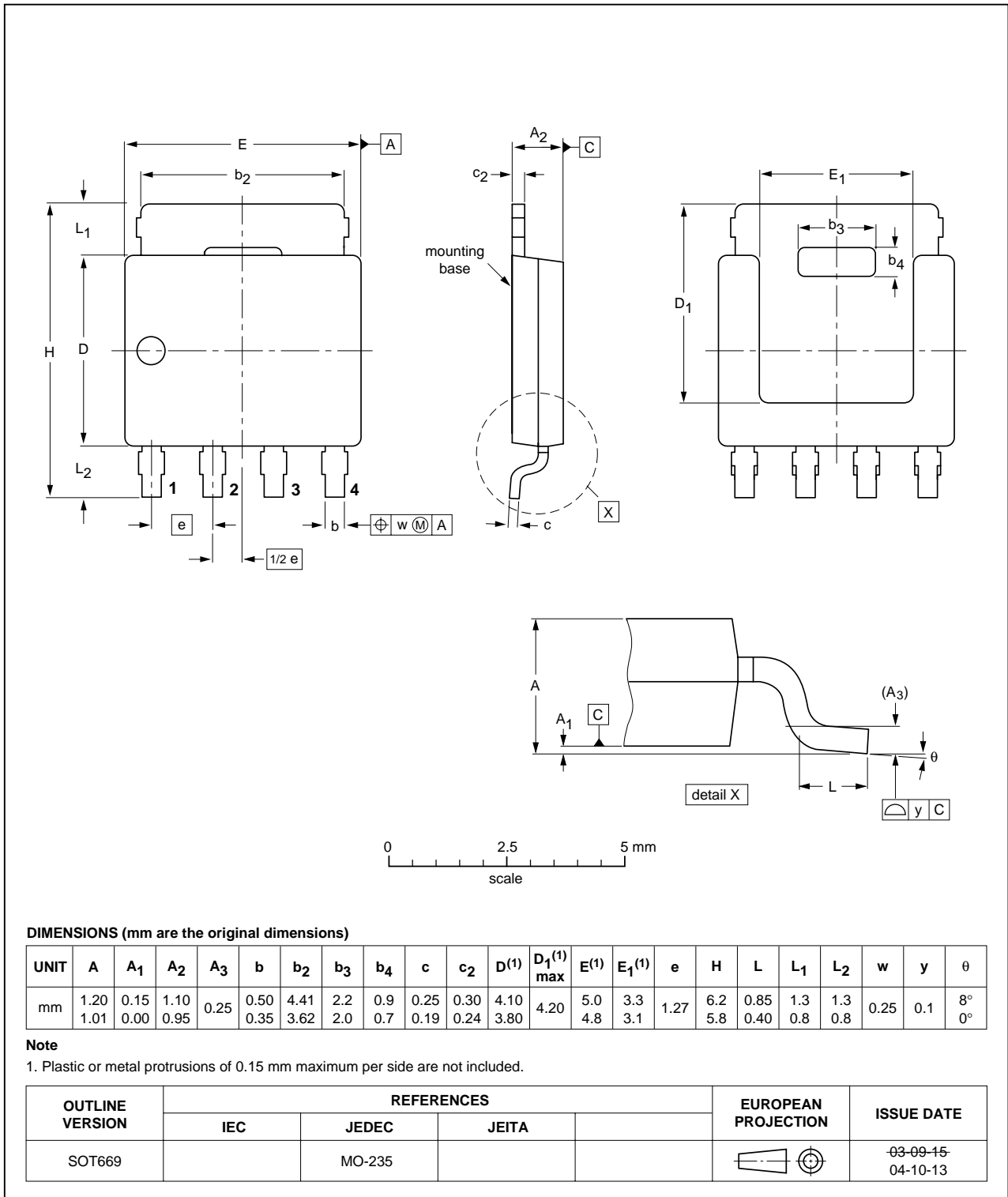**Plastic single-ended surface mounted package (LFPAK); 4 leads**　　　　　**SOT669**

DIMENSIONS (mm are the original dimensions)

UNIT	A	A₁	A₂	A₃	b	b₂	b₃	b₄	c	c₂	D$^{(1)}$	D₁$^{(1)}$ max	E$^{(1)}$	E₁$^{(1)}$	e	H	L	L₁	L₂	w	y	θ
mm	1.20 1.01	0.15 0.00	1.10 0.95	0.25	0.50 0.35	4.41 3.62	2.2 2.0	0.9 0.7	0.25 0.19	0.30 0.24	4.10 3.80	4.20	5.0 4.8	3.3 3.1	1.27	6.2 5.8	0.85 0.40	1.3 0.8	1.3 0.8	0.25	0.1	8° 0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT669		MO-235				~~03-09-15~~ 04-10-13

Fig 15. Package outline SOT669 (LFPAK)

8. Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PH1875L_1	20051129	Product data sheet	-	-	-

9. Data sheet status

Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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